

| | Type | Hits | Search Text | DBs |
|----|------|------|---|---|
| 24 | BRS | 2170 | (single\$2event (single adj event)) and circuit | US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB |
| 25 | BRS | 0 | S19 and (magnetic radiation) | US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB |
| 26 | BRS | 0 | S21 and feedback | US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB |
| 27 | BRS | 2170 | (single\$2event (single adj event)) and circuit | US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB |
| 28 | BRS | 1063 | S27 and (magnetic radiation) | US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB |
| 29 | BRS | 340 | S28 and feedback | US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB |
| 30 | BRS | 2171 | (single\$2event (single adj event)) and circuit | US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB |
| 31 | BRS | 1 | S30 and (silicon\$2on\$2insulator and (bulk\$2silicon)) | US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB |
| 32 | BRS | 1 | S30 and ((bulk\$2silicon)) | US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB |
| 33 | BRS | 49 | S30 and ((bulk\$2silicon bulk adj silicon)) | US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB |

| | Type | Hits | Search Text | DBs |
|----|------|------|---|---|
| 34 | BRS | 404 | (single\$2event (single adj event)) and bulk | US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB |